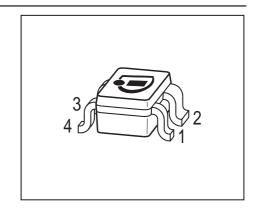


NPN Silicon RF Transistor*

- For low noise, high-gain broadband amplifiers at collector currents from 2 mA to 30 mA
- $f_T = 8 \text{ GHz}$, F = 0.9 dB at 900 MHz
- * Short term description



ESD (Electrostatic discharge) sensitive device, observe handling precaution!

Туре	Marking	Pin Configuration					Package	
BFP183W	RHs	1=E	2=C	3=E	4=B	-	-	SOT343

Maximum Ratings

Parameter	Symbol	Value	Unit	
Collector-emitter voltage	$V_{\sf CEO}$	12	V	
Collector-emitter voltage	V_{CES}	20		
Collector-base voltage	V_{CBO}	20		
Emitter-base voltage	V_{EBO}	2		
Collector current	I _C	65	mA	
Base current	I _B	5		
Total power dissipation ¹⁾	P _{tot}	450	mW	
<i>T</i> _S ≤ 58 °C				
Junction temperature	T_{i}	150	°C	
Ambient temperature	T_{A}	-65 150		
Storage temperature	$T_{ m stg}$	-65 150		

Thermal Resistance

Parameter	Symbol	Value	Unit
Junction - soldering point ²⁾	R _{thJS}	≤ 205	K/W

 $^{^1}T_{\mathrm{S}}$ is measured on the collector lead at the soldering point to the pcb

 $^{^{2}}$ For calculation of R_{thJA} please refer to Application Note Thermal Resistance



Electrical Characteristics at $T_A = 25$ °C, unless otherwise specified

Parameter	Symbol	Values			Unit
		min.	typ.	max.	
DC Characteristics				•	•
Collector-emitter breakdown voltage	V _{(BR)CEO}	12	-	-	V
$I_{\rm C} = 1 \text{ mA}, I_{\rm B} = 0$					
Collector-emitter cutoff current	I _{CES}	-	-	100	μΑ
$V_{CE} = 20 \text{ V}, \ V_{BE} = 0$					
Collector-base cutoff current	I _{CBO}	-	-	100	nA
$V_{CB} = 10 \text{ V}, I_{E} = 0$					
Emitter-base cutoff current	l _{EBO}	-	-	1	μA
$V_{\rm EB} = 1 \text{ V}, I_{\rm C} = 0$					
DC current gain-	h _{FE}	70	100	140	-
$I_{\rm C}$ = 15 mA, $V_{\rm CE}$ = 8 V, pulse measured					



Electrical Characteristics at $T_A = 25$ °C, unless otherwise specified

Parameter	Symbol	Values			Unit
		min.	typ.	max.	
AC Characteristics (verified by random samplin	g)				
Transition frequency	f_{T}	6	8	-	GHz
$I_{C} = 25 \text{ mA}, \ V_{CE} = 8 \text{ V}, \ f = 500 \text{ MHz}$					
Collector-base capacitance	C_{cb}	-	0.34	0.54	pF
$V_{CB} = 10 \text{ V}, f = 1 \text{ MHz}, V_{BE} = 0,$					
emitter grounded					
Collector emitter capacitance	C_{ce}	-	0.27	-	
$V_{CE} = 10 \text{ V}, f = 1 \text{ MHz}, V_{BE} = 0,$					
base grounded					
Emitter-base capacitance	C _{eb}	_	1.1	_	
$V_{EB} = 0.5 \text{ V}, f = 1 \text{ MHz}, V_{CB} = 0$,					
collector grounded					
Noise figure	F				dB
$I_{\rm C} = 5 \text{ mA}, \ V_{\rm CE} = 8 \text{ V}, \ Z_{\rm S} = Z_{\rm Sopt},$					
f = 900 MHz		-	0.9	-	
f = 1.8 GHz		-	1.4	-	
Power gain, maximum stable ¹⁾	G _{ms}	-	22	-	dB
$I_{\rm C} = 15 \text{ mA}, \ V_{\rm CE} = 8 \text{ V}, \ Z_{\rm S} = Z_{\rm Sopt}, \ Z_{\rm L} = Z_{\rm Lopt},$					
f = 900 MHz					
Power gain, maximum available ¹⁾	G _{ma}	-	15.5	-	dB
$I_{C} = 15 \text{ mA}, \ V_{CE} = 8 \text{ V}, \ Z_{S} = Z_{Sopt}, \ Z_{L} = Z_{Lopt}$					
f = 1.8 GHz					
Transducer gain	S _{21e} ²				dB
$I_{\rm C} = 15 \text{ mA}, \ V_{\rm CE} = 8 \text{ V}, \ Z_{\rm S} = Z_{\rm L} = 50 \ \Omega,$					
f = 900 MHz		-	17.5	-	
f = 1.8 MHz		-	11.5	-	
	1				

 $^{^{1}}G_{\text{ma}} = |S_{21e} / S_{12e}| \text{ (k-(k^2-1)^{1/2})}, \ G_{\text{ms}} = |S_{21} / S_{12}|$



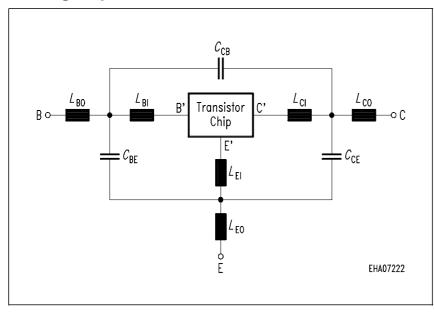
SPICE Parameter (Gummel-Poon Model, Berkley-SPICE 2G.6 Syntax):

Transitor Chip Data:

IS =	1.0345	fA	BF =	115.98	-	NF =	0.80799	-
VAF =	14.772	V	IKF =	0.14562	Α	ISE =	16.818	fA
NE =	1.2149	-	BR =	10.016	-	NR =	0.99543	-
VAR =	3.4276	V	IKR =	0.013483	Α	ISC =	1.3559	fA
NC =	0.85331	-	RB =	2.5426	Ω	IRB =	0.43801	mΑ
RBM =	1.0112	Ω	RE =	1.3435	-	RC =	0.20486	Ω
CJE =	23.077	fF	VJE =	1.0792	V	MJE =	0.45354	-
TF =	22.746	ps	XTF =	0.36823	-	VTF =	0.50905	V
ITF =	1.8773	mA	PTF =	0	deg	CJC =	460.11	fF
VJC =	1.1967	V	MJC =	0.3	-	XCJC =	0.053823	-
TR =	1.0553	ns	CJS =	0	fF	VJS =	0.75	V
MJS =	0	-	XTB =	0	-	EG =	1.11	eV
XTI =	3	-	FC =	0.54852		TNOM	300	K

All parameters are ready to use, no scalling is necessary. Extracted on behalf of Infineon Technologies AG by: Institut für Mobil- und Satellitentechnik (IMST)

Package Equivalent Circuit:



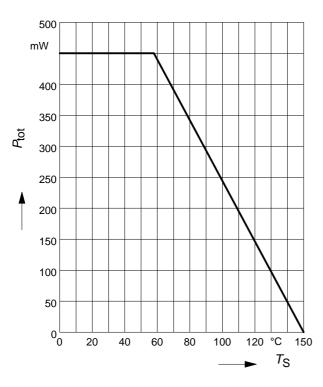
$$L_{\rm BI} = 0.43$$
 nH $L_{\rm BO} = 0.47$ nH $L_{\rm EI} = 0.26$ nH $L_{\rm EO} = 0.12$ nH $L_{\rm CI} = 0.06$ nH $L_{\rm CO} = 0.36$ nH $L_{\rm CO} = 68$ fF $L_{\rm CE} = 68$ fF

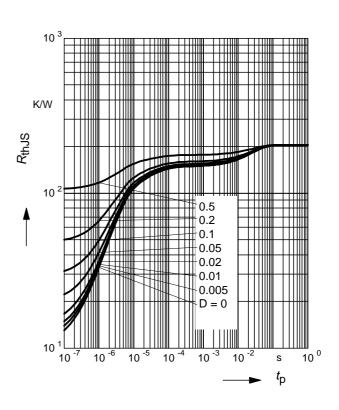
For examples and ready to use parameters please contact your local Infineon Technologies distributor or sales office to obtain a Infineon Technologies CD-ROM or see Internet: http://www.infineon.com/silicondiscretes



Total power dissipation $P_{tot} = f(T_S)$

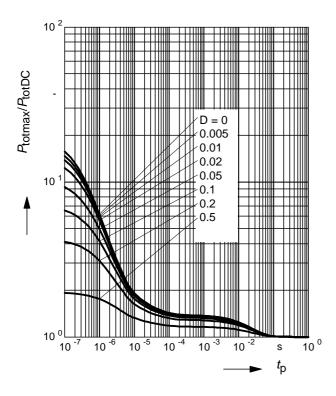
Permissible Pulse Load $R_{thJS} = f(t_p)$





Permissible Pulse Load

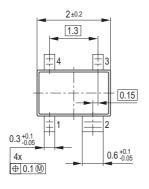
$$P_{\text{totmax}}/P_{\text{totDC}} = f(t_{p})$$

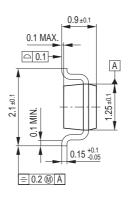




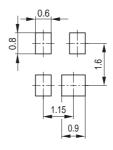
Package Outline



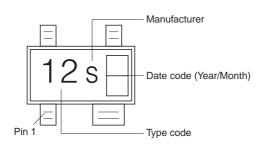


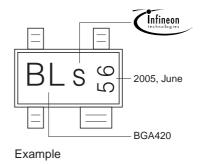


Foot Print



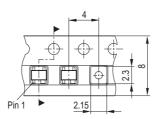
Marking Layout





Standard Packing

Reel ø180 mm = 3.000 Pieces/Reel Reel ø330 mm = 10.000 Pieces/Reel







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